

<b>Notice of References Cited</b>	Application/Control No. 09/490,772	Applicant(s)/Patent Under Reexamination HOHENSEE ET AL.	
	Examiner CHAN S. PARK	Art Unit 2625	Page 1 of 1

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*	B	US-7,126,717	10-2006	Jeyachandran et al.	358/1.9
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